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Titolo	Deterministic and statistical methods in machine learning : first international workshop, Sheffield, UK, September 7-10, 2004 : revised lectures // Joab Winkler, Mahesan Niranjan, Neil Lawrence (eds.)
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Disciplina	006.3
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Note generali	"Sheffield Machine Learning Workshop"--Pref.
Nota di bibliografia	Includes bibliographical references and index.
Nota di contenuto	Object Recognition via Local Patch Labelling -- Multi Channel Sequence Processing -- Bayesian Kernel Learning Methods for Parametric Accelerated Life Survival Analysis -- Extensions of the Informative Vector Machine -- Efficient Communication by Breathing -- Guiding Local Regression Using Visualisation -- Transformations of Gaussian Process Priors -- Kernel Based Learning Methods: Regularization Networks and RBF Networks -- Redundant Bit Vectors for Quickly Searching High-Dimensional Regions -- Bayesian Independent Component Analysis with Prior Constraints: An Application in Biosignal Analysis -- Ensemble Algorithms for Feature Selection -- Can Gaussian Process Regression Be Made Robust Against Model Mismatch? -- Understanding Gaussian Process Regression Using the Equivalent Kernel -- Integrating Binding Site Predictions Using Non-linear Classification Methods -- Support Vector Machine to Synthesise Kernels -- Appropriate Kernel Functions for Support Vector Machine Learning with Sequences of Symbolic Data -- Variational Bayes Estimation of Mixing Coefficients -- A Comparison of Condition Numbers for the Full Rank Least Squares Problem -- SVM Based Learning System for Information Extraction.

